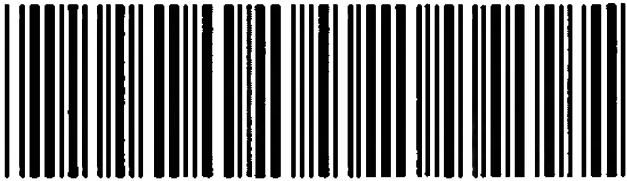
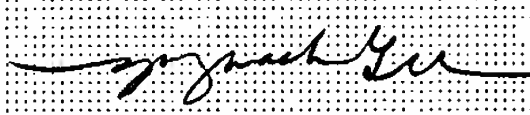
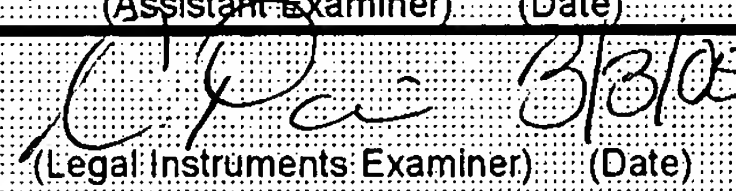


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/631,319	RHEE, SHIN W.	
	Examiner	Art Unit	
	Y Quach Lee	2875	

ISSUE CLASSIFICATION												
ORIGINAL					CROSS REFERENCE(S)							
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
362		490			362	147	374					
INTERNATIONAL CLASSIFICATION												
F	2	1	V	21/00								
				/								
				/								
				/								
				/								
					Total Claims Allowed: 19							
(Assistant Examiner) (Date)					 Y. MY QUACH-LEE 2/22/05 PRIMARY EXAMINER (Primary Examiner) (Date)				O.G. Print Claim(s)		O.G. Print Fig.	
 (Legal Instruments Examiner) (Date)									1		1	

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant												<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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